International TOR Rectifier

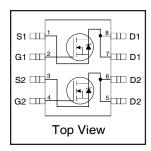
PD -95037B **IRF7103PbF**

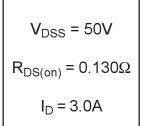
HEXFET® Power MOSFET

- Adavanced Process Technology
- Ultra Low On-Resistance
- Dual N-Channel MOSFET
- Surface Mount
- Available in Tape & Reel
- Dynamic dv/dt Rating
- Fast Switching
- Lead-Free

Description

The SO-8 has been modified through a customized leadframe for enhanced thermal characteristics and dual-die capability making it ideal in a variety of power applications. With these improvements, multiple devices can be used in an application with dramatically reduced board space. The package is designed for vapor phase, infra red, or wave soldering techniques. Power dissipation of greater than 0.8W is possible in a typical PCB mount application.







Absolute Maximum Ratings

| | Parameter | Max. | Units |
|--|---|--------------|-------|
| I _D @ T _A = 25°C | Continuous Drain Current, V _{GS} @ 10V | 3.0 | |
| I _D @ T _A = 70°C Continuous Drain Current, V _{GS} @ 10V | | 2.3 | A |
| I _{DM} | Pulsed Drain Current ① | 10 | |
| P _D @T _A = 25°C | Power Dissipation | 2.0 | W |
| | Linear Derating Factor | 0.016 | W/°C |
| V_{GS} | Gate-to-Source Voltage | ± 20 | V |
| dv/dt | Peak Diode Recovery dv/dt ② | 4.5 | V/nS |
| T _{J,} T _{STG} | Junction and Storage Temperature Range | -55 to + 150 | ℃ |

Thermal Resistance Ratings

| | Parameter | Min. | Тур. | Max. | Units |
|-----------------|-------------------------------|------|------|------|-------|
| $R_{\theta JA}$ | Maximum Junction-to-Ambient ④ | | | 62.5 | °C/W |

Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

| | Parameter | Min. | Тур. | Max. | Units | Conditions | |
|---------------------------------|--|------|-------|------|-------|---|--|
| $V_{(BR)DSS}$ | Drain-to-Source Breakdown Voltage | 50 | | | V | $V_{GS} = 0V, I_{D} = 250\mu A$ | |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient | | 0.049 | | V/°C | Reference to 25°C, I _D = 1mA | |
| | Static Drain-to-Source On-Resistance | | 0.11 | 0.13 | Ω | V _{GS} = 10V, I _D = 3.0A ③ | |
| R _{DS(ON)} | Static Dialif-to-Source Off-Resistance | | 0.16 | 0.20 | 52 | V _{GS} = 4.5V, I _D = 1.5A ③ | |
| V _{GS(th)} | Gate Threshold Voltage | 1.0 | | 3.0 | V | $V_{DS} = V_{GS}, I_{D} = 250 \mu A$ | |
| g _{fs} | Forward Transconductance | | 3.8 | | S | V _{DS} = 15V, I _D = 3.0A ③ | |
| 1 | Drain to Course Leekage Current | | | 2.0 | | V _{DS} = 40V, V _{GS} = 0V | |
| IDSS | Drain-to-Source Leakage Current | | | 25 | μA | V _{DS} = 40V, V _{GS} = 0V, T _J = 55 °C | |
| Lead | Gate-to-Source Forward Leakage | | | 100 | nA | V _{GS} = 20V | |
| I _{GSS} | Gate-to-Source Reverse Leakage | | | -100 | IIA | V _{GS} = - 20V | |
| Qg | Total Gate Charge | | 12 | 30 | | I _D = 2.0A | |
| Q _{gs} | Gate-to-Source Charge | | 1.2 | | nC | V _{DS} = 25V | |
| Q _{gd} | Gate-to-Drain ("Miller") Charge | | 3.5 | | | V _{GS} = 10V ③ | |
| t _{d(on)} | Turn-On Delay Time | | 9.0 | 20 | | V _{DD} = 25V | |
| t _r | Rise Time | | 8.0 | 20 | | I _D = 1.0A | |
| t _{d(off)} | Turn-Off Delay Time | | 45 | 70 | ns | $R_G = 6.0\Omega$ $R_D = 25\Omega$ ③ | |
| t _f | Fall Time | | 25 | 50 | | | |
| L _D | Internal Drain Inductance | | 4.0 | | nH | Between lead,6mm(0.25in.) | |
| L _S | Internal Source Inductance | _ | 6.0 | _ | 1111 | from package and center of die contact | |
| C _{iss} | Input Capacitance | | 290 | | | V _{GS} = 0V | |
| Coss | Output Capacitance | | 140 | | рF | V _{DS} = 25V | |
| C _{rss} | Reverse Transfer Capacitance | | 37 | | | f = 1.0MHz | |

Source-Drain Ratings and Characteristics

| | Parameter | Min. | Тур. | Max. | Units | Conditions | | | | |
|-----------------|---------------------------|---|---------|------|-------|--|----|----|---|------------------|
| ls | Continuous Source Current | | | 2.0 | | MOSFET symbol | | | | |
| | (Body Diode) | | | 2.0 | | showing the | | | | |
| I _{SM} | Pulsed Source Current | | | 12 | 40 | 40 | 40 | 40 | Α | integral reverse |
| | (Body Diode) ① | | — i — i | | | p-n junction diode. | | | | |
| V _{SD} | Diode Forward Voltage | | | 1.2 | V | $T_J = 25$ °C, $I_S = 1.5$ A, $V_{GS} = 0$ V ③ | | | | |
| t _{rr} | Reverse Recovery Time | | 70 | 100 | ns | $T_J = 25$ °C, $I_F = 1.5A$ | | | | |
| Q _{rr} | Reverse RecoveryCharge | | 110 | 170 | nC | di/dt = 100A/µs ③ | | | | |
| t _{on} | Forward Turn-On Time | Intrinsic turn-on time is negligible (turn-on is dominated by L_S+L_D) | | | | | | | | |

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- $\begin{tabular}{ll} @ & I_{SD} \le 1.8A, & di/dt \le 90A/\mu s, & V_{DD} \le V_{(BR)DSS}, \\ & T_{J} \le 150 ^{\circ}C \end{tabular}$
- 4 Surface mounted on FR-4 board, $t \leq 10$ sec.

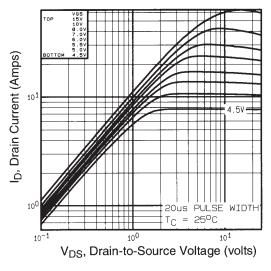


Fig 1. Typical Output Characteristics,

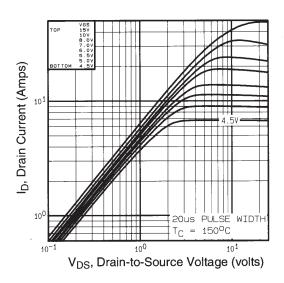


Fig 2. Typical Output Characteristics,

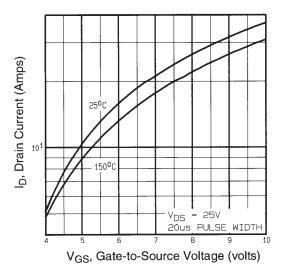


Fig 3. Typical Transfer Characteristics

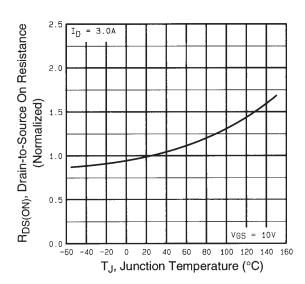


Fig 4. Normalized On-Resistance Vs. Temperature

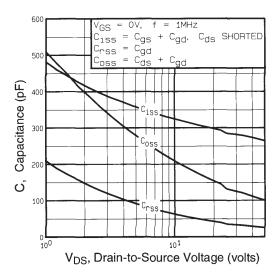


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

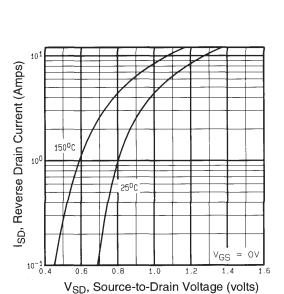


Fig 7. Typical Source-Drain Diode Forward Voltage

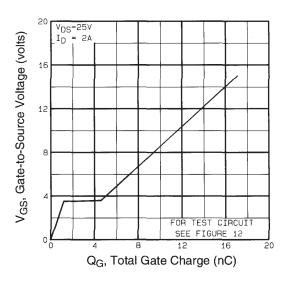


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

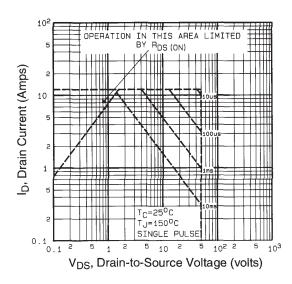


Fig 8. Maximum Safe Operating Area

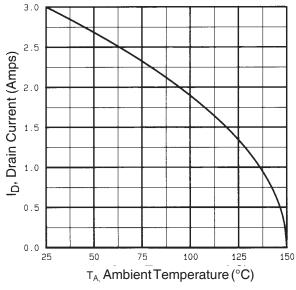


Fig 9. Maximum Drain Current Vs. Ambient Temperature

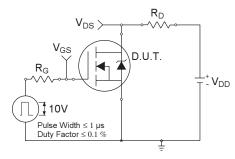


Fig 10a. Switching Time Test Circuit

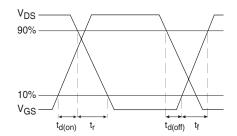


Fig 10b. Switching Time Waveforms

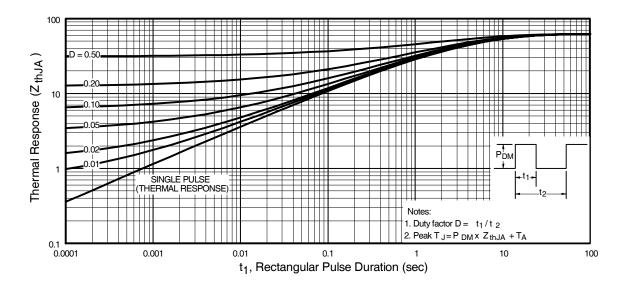
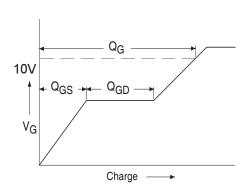


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

International Rectifier



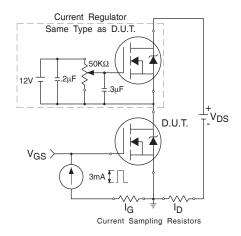
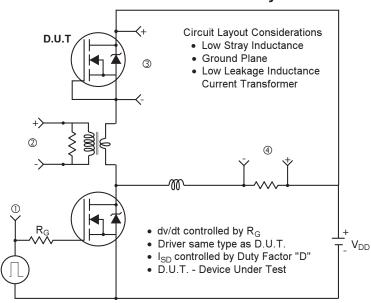


Fig 12a. Basic Gate Charge Waveform

Fig 12b. Gate Charge Test Circuit

Peak Diode Recovery dv/dt Test Circuit



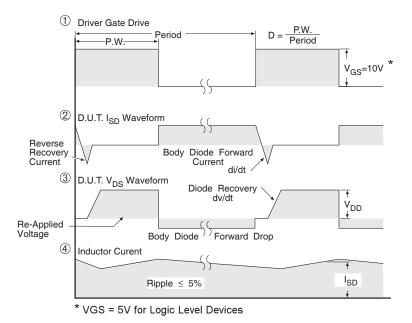
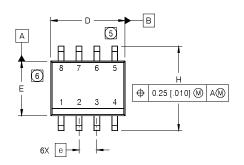


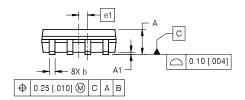
Fig 13. For N-Channel HEXFETS

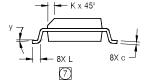
International IOR Rectifier

SO-8 Package Outline (Mosfet & Fetky) Dimensions are shown in milimeters (inches)

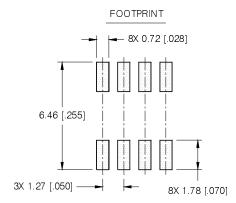


| DIM | INC | HES | MILLIMETERS | | |
|-----|------------|-------|-------------|------|--|
| DIM | MIN | MAX | MIN | MAX | |
| Α | .0532 | .0688 | 1.35 | 1.75 | |
| A1 | .0040 | .0098 | 0.10 | 0.25 | |
| b | .013 | .020 | 0.33 | 0.51 | |
| С | .0075 | .0098 | 0.19 | 0.25 | |
| D | .189 | .1968 | 4.80 | 5.00 | |
| Е | .1497 | .1574 | 3.80 | 4.00 | |
| е | .050 BASIC | | 1.27 BASIC | | |
| e 1 | .025 BASIC | | 0.635 BASIC | | |
| Н | .2284 | .2440 | 5.80 | 6.20 | |
| K | .0099 | .0196 | 0.25 | 0.50 | |
| L | .016 | .050 | 0.40 | 1.27 | |
| У | 0° | 8° | 0° | 8° | |

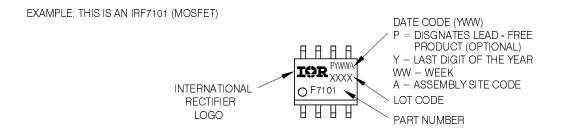




- 1. DIMENSIONING & TOLERANCING PER ASME Y14.5M-1994
- 2. CONTROLLING DIMENSION: MILLIMETER
- 3. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 4. OUTLINE CONFORMS TO JEDEC OUTLINE MS-012AA.
- (5) DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS. MOLD PROTRUSIONS NOT TO EXCEED 0.15 [.006].
- 6 DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS MOLD PROTRUSIONS NOT TO EXCEED 0.25 [.010].
- 7 DIMENSION IS THE LENGTH OF LEAD FOR SOLDERING TO A SUBSTRATE

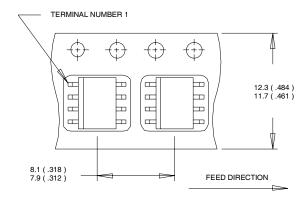


SO-8 Part Marking Information



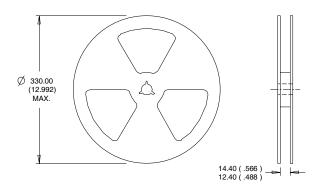
Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

SO-8 Tape and Reel (Dimensions are shown in milimeters (inches))



NOTES:

- 1. CONTROLLING DIMENSION : MILLIMETER.
- ALL DIMENSIONS ARE SHOWN IN MILLIMETERS(INCHES).
- 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



- 1. CONTROLLING DIMENSION : MILLIMETER.
 2. OUTLINE CONFORMS TO EIA-481 & EIA-541.

Data and specifications subject to change without notice. This product has been designed and qualified for the Consumer market. Qualifications Standards can be found on IR's Web site.

> International IOR Rectifier

IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105

TAC Fax: (310) 252-7903

Visit us at www.irf.com for sales contact information.02/2010

Mouser Electronics

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

Infineon:

IRF7103PBF IRF7103TRPBF